Application/Control No. Applicant(s)/Patent Under Reexamination 10/077,192 LAWRENCE ET AL. Notice of References Cited Art Unit Examiner Page 1 of 1 3629 Tan Dean D. Nguyen **U.S. PATENT DOCUMENTS Document Number** Date Name Classification Country Code-Number-Kind Code MM-YYYY US-2001/0026609 10-2001 Α Weinstein et al. 379/93.01 US-В US-С US-D US-Ε F US-G US-Н US-US-1 US-J K US-US-L М US-**FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY 2254378 10-1999 Canada Ν Woodrow 0 02540 4-2001 Kovea Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U ٧ W

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).) Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Х